

Notice of References CitedApplication/Control No.
10/030,618Applicant(s)/Patent Under Reexam
Kanai et al.Examiner
Bruck Kifle, Ph.D.Art Unit
1624

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U	Cantrell et al. (Natural Product Letters (1999). Abstract.
V	Schupp et al. (Journal of Natural Products (1999), 62(7), 959-962). Abstract.
W	Yamada et al. (Journal of Antibiotics (1996), 49(10), 1070-1072). Abstract.
X	Funato et al. (Tetrahedron Letters (1994), 35(8), 1251-4). Abstract.

* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

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U	JP 05140168 (1993). Abstract.
V	Kinnet et al. (Journal of Organic Chemistry (1992), 57(23), 6327-9). Abstract.
W	Tsubotani et al. (Tetrahedron (1991), 47(22), 3565-74). Abstract.
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